


<b>Search Notes</b>  	<b>Application/Control No.</b>  10584156	<b>Applicant(s)/Patent Under Reexamination</b>  SCHNEIDER ET AL.
	<b>Examiner</b>  Binh X Tran	<b>Art Unit</b>  1792

SEARCHED			
Class	Subclass	Date	Examiner
427	249.1, 249.3, 249.9	05/07/2009	BT
977	942, 775	05/07/2009	BT

SEARCH NOTES		
Search Notes	Date	Examiner
Search inventor's name	5/6/2009	BT
Search keywords using database in EAST	5/6/2009	BT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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